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Listing of Claims:

- 1. (Previously Presented) Apparatus for gas distribution in a semiconductor wafer processing chamber comprising:
 - a roof fabricated from a silicon-based material and having a center gas feed;
 - a recess disposed within said roof;
- a gas distribution plate disposed within said recess and having a plurality of blind radial grooves in fluid communication with the center gas feed; and
- a plurality of apertures disposed within said grooves and extending through the gas distribution plate.
- 2. (Withdrawn) The apparatus of claim 1 wherein the recess is disposed on a top surface of the roof.
- (Withdrawn) The apparatus of claim 2 wherein a seal circumscribes gas distribution plate.
- 4. (Withdrawn) The apparatus of claim 2 wherein the roof further comprises a plurality of grooves formed in the recess.
- 5. (Withdrawn) The apparatus of claim 4 wherein the plurality of apertures disposed with the roof extend from each of said plurality of grooves into a bottom surface of the roof.
- 6. (Original) The apparatus of claim 1 wherein the roof is fabricated from silicon carbide.
- 7. (Original) The apparatus of claim 1 wherein the gas distribution plate is fabricated from silicon carbide.

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- 8. (Original) The apparatus of claim 1 wherein the recess is formed on a bottom surface of the roof.
- 9. (Original) The apparatus of claim 8 wherein a gas feed channel extends from the top surface of the roof to the recess.
- 10. (Original) The apparatus of claim 8 wherein the bottom surface of the roof and the gas distribution plate are covered by a material layer.
- 11. (Original) The apparatus of claim 10 wherein the material layer is silicon carbide.
- 12. (Original) The apparatus of claim 11 wherein the material layer is deposited by chemical vapor deposition (CVD).
- 13. (Original) The apparatus of claim 10 wherein the material layer further comprises a plurality of apertures disposed therein.
- 14-15. (Cancelled)
- 16. (Original) The apparatus of claim 8 wherein the roof is fabricated from silicon carbide.
- 17. (Original) The apparatus of claim 8 wherein the gas distribution plate is fabricated from silicon carbide.
- 18. (Currently Amended) Apparatus for gas distribution in a semiconductor wafer processing chamber comprising:
 - a roof having a top surface and a bottom surface and having a center gas feed; a recess disposed within the bottom surface of said roof;

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a gas distribution plate disposed within said recess and having a plurality of blind radial grooves in a fluid communication with the center gas feed[[;]] and a plurality of apertures disposed within said grooves, the apertures extending through the gas distribution plate; and

a material layer coating disposed upon the bottom surface of the roof and the gas distribution plate.

- 19. (Original) The apparatus of claim 18 wherein the material layer coating further comprises a plurality of apertures.
- 20. (Cancelled)
- 21. (Currently Amended) The apparatus of claim 18 [[20]] wherein the apertures in [[of]] the gas distribution plate coincide with the apertures in the material layer coating.
- 22. (Original) The apparatus of claim 18 wherein the material layer coating is formed from silicon carbide.
- 23. (Original) The apparatus of claim 18 wherein the material layer is deposited by chemical vapor deposition (CVD).
- 24. (Original) The apparatus of claim 18 wherein the roof is fabricated from silicon carbide.
- 25. (Original) The apparatus of claim 18 wherein the gas distribution plate is fabricated from silicon carbide.
- 26. (Previously Presented) The apparatus of claim 13 wherein the apertures of the gas distribution plate coincide with the apertures in the material layer.